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Title:Improved external base resistance extraction for submicrometer InP/InGaAs DHBT models

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Abstract: An improved direct parameter extraction method is proposed for III-V heterojunction bipolar transistor (HBT) external base resistance R_{bx} extraction from forward active S-parameters. The method is formulated taking into account the current dependence of the intrinsic base-collector capacitance found in III-V HBTs with a fully depleted collector. It is shown that the real part of $Z_{11} - Z_{12}$ reduces to the external base resistance at the collector current $I_c = I_p / (1 - X_0)$, where I_p is a characteristic current and X_0 is the zero-current distribution factor given as the ratio of the emitter to the collector area. The determination of the parameters I_p and X_0 from experimental S-parameters is described. The method is applied to high-speed submicrometer InP/InGaAs DHBT devices and leads to small-signal equivalent circuit models, which accurately predicts the measured S-parameters as well as the maximum stable power gain/maximum available power gain in the frequency range from 40 MHz to 110 GHz.